ţ	Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/623,253	SENTANI ET AL.
Examiner	Art Unit
EDMUND H. LEE	1732

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEAR(CH NOTES	RATEGY)
		DATE	EXMR
updated	8	8/21/2006	EHL
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